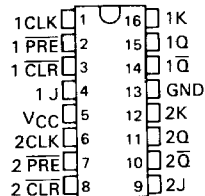


TYPES SN5476, SN54H76, SN54LS76A, SN7476, SN74H76, SN74LS76A DUAL J-K FLIP-FLOPS WITH PRESET AND CLEAR

REVISED DECEMBER 1983

- Package Options Include Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

SN5476, SN54H76, SN54LS76A . . . J OR W PACKAGE
SN7476, SN74H76 . . . J OR N PACKAGE
SN74LS76A . . . D, J OR N PACKAGE
(TOP VIEW)



description

The '76 and 'H76 contain two independent J-K flip-flops with individual J-K, clock, preset, and clear inputs. The '76 and 'H76 are positive-edge-triggered flip-flops. J-K input is loaded into the master while the clock is high and transferred to the slave on the high-to-low transition. For these devices the J and K inputs must be stable while the clock is high.

The 'LS76A contain two independent negative-edge-triggered flip-flops. The J and K inputs must be stable one setup time prior to the high-to-low clock transition for predictable operation. The preset and clear are asynchronous active low inputs. When low they override the clock and data inputs forcing the outputs to the steady state levels as shown in the function table.

The SN5476, SN54H76, and the SN54LS76A are characterized for operation over the full military temperature range of -55°C to 125°C . The SN7476, SN74H76, and the SN74LS76A are characterized for operation from 0°C to 70°C .

'76, 'H76
FUNCTION TABLE

INPUTS					OUTPUTS	
PRE	CLR	CLK	J	K	Q	\bar{Q}
L	H	X	X	X	H	L
H	L	X	X	X	L	H
L	L	X	X	X	H [†]	H [†]
H	H	\downarrow	L	L	Q ₀	\bar{Q}_0
H	H	\downarrow	H	L	H	L
H	H	\downarrow	L	H	L	H
H	H	\downarrow	H	H	TOGGLE	
H	H	\downarrow	H	H	Q ₀	\bar{Q}_0

'LS76A
FUNCTION TABLE

INPUTS					OUTPUTS	
PRE	CLR	CLK	J	K	Q	\bar{Q}
L	H	X	X	X	H	L
H	L	X	X	X	L	H
L	L	X	X	X	H [†]	H [†]
H	H	\downarrow	L	L	Q ₀	\bar{Q}_0
H	H	\downarrow	H	L	H	L
H	H	\downarrow	L	H	L	H
H	H	\downarrow	H	H	TOGGLE	
H	H	\downarrow	H	X	Q ₀	\bar{Q}_0

[†] This configuration is nonstable; that is, it will not persist when either preset or clear returns to its inactive (high) level.

FOR CHIP CARRIER INFORMATION,
CONTACT THE FACTORY

PRODUCTION DATA

This document contains information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.


**TEXAS
INSTRUMENTS**

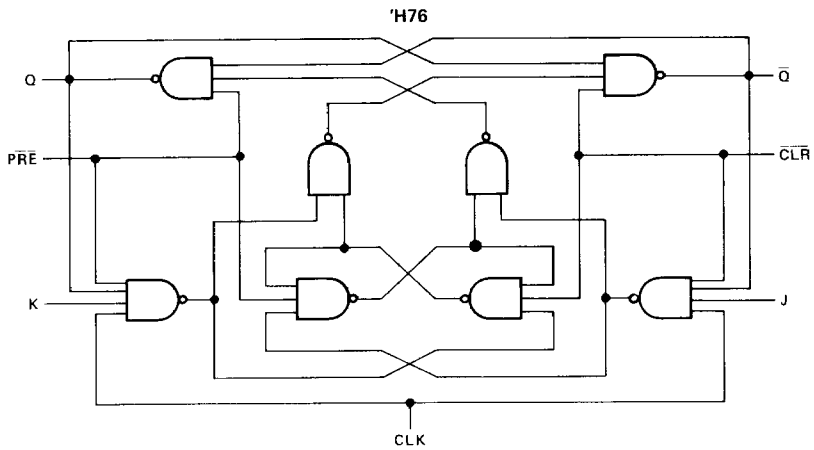
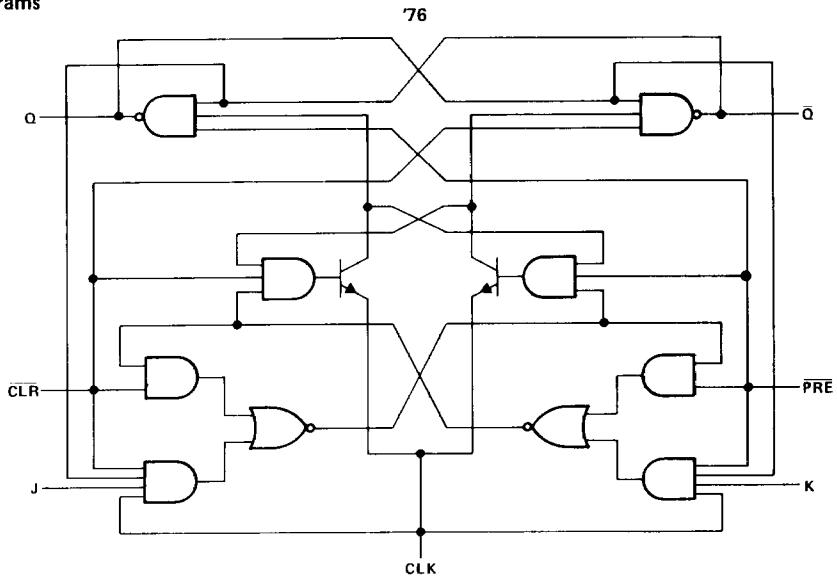
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TTL DEVICES

TYPES SN5476, SN54H76,
 SN7476, SN74H76
 DUAL J-K FLIP-FLOPS WITH PRESET AND CLEAR

logic diagrams

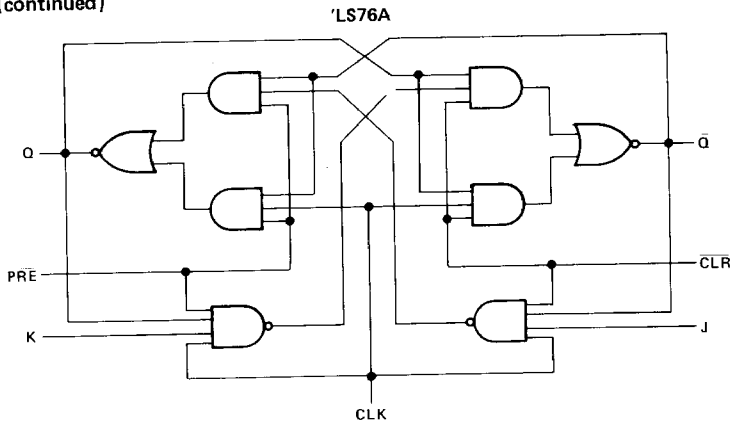


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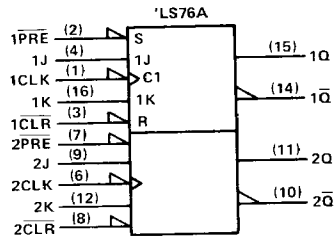
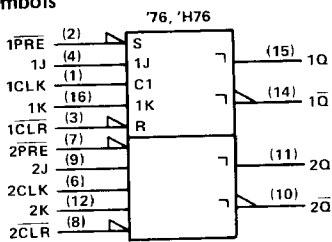
TTL DEVICES

TYPES SN5476, SN54H76, SN54LS76A,
SN7476, SN74H76, SN74LS76A
DUAL J-K FLIP-FLOPS WITH PRESET AND CLEAR

logic diagrams (continued)

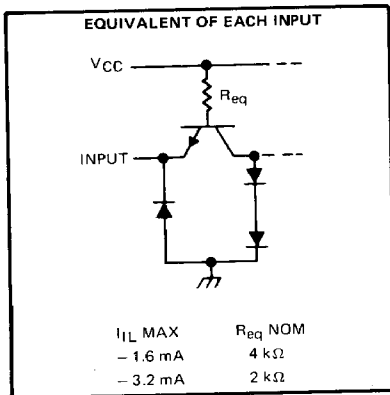


logic symbols

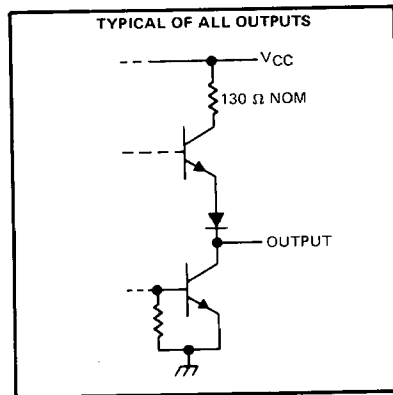


Pin numbers shown on logic notation are for D, J or N packages.

schematics of inputs and outputs



'76



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TTL DEVICES

TYPES SN5476, SN7476 DUAL J-K FLIP-FLOPS WITH PRESET AND CLEAR

recommended operating conditions

	SN5476			SN7476			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V _{IH} High-level input voltage	2			2			V
V _{IL} Low-level input voltage			0.8			0.8	V
I _{OH} High-level output current			-0.4			-0.4	mA
I _{OL} Low-level output current			16			16	mA
t _w Pulse duration	CLK high	20		20			ns
	CLK low	47		47			
	PRE or CLR low	25		25			
t _{SU} Input setup time before CLK ↑	0			0			ns
t _H Input hold time-data after CLK ↓	0			0			ns
T _A Operating free-air temperature	-55	125		0	70		°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	SN5476			SN7476			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	
V _{IK}	V _{CC} = MIN, I _I = -12 mA			-1.5			-1.5	V
V _{OH}	V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V, I _{OH} = -0.4 mA	2.4	3.4		2.4	3.4		V
V _{OL}	V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V, I _{OL} = 16 mA		0.2	0.4		0.2	0.4	V
I _I	V _{CC} = MAX, V _I = 5.5 V			1			1	mA
I _{IH}	J or K			40			40	μA
	All other	V _{CC} = MAX, V _I = 2.4 V		80			80	
I _{IL}	J or K			-1.6			-1.6	mA
	All other★	V _{CC} = MAX, V _I = 0.4 V		-3.2			-3.2	
I _{OS} ‡	V _{CC} = MAX	-20		-57	-18		-57	mA
I _{CC}	V _{CC} = MAX, See Note 2		10	20		10	20	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.

§ Not more than one output should be shorted at a time.

* Clear is tested with preset high and preset is tested with clear high.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and \bar{Q} outputs high in turn. At the time of measurement, the clock input is grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{max}			R _L = 400 Ω, C _L = 15 pF	15	20		MHz
t _{PLH}	PRE or CLR	Q or \bar{Q}			16	25	ns
t _{PHL}					25	40	ns
t _{PLH}	CLK	Q or \bar{Q}			16	25	ns
t _{PHL}					25	40	ns

NOTE 3: See General Information Section for load circuits and voltage waveforms.

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TTL DEVICES

TYPES SN54H76, SN74H76 DUAL J-K FLIP-FLOPS WITH PRESET AND CLEAR

recommended operating conditions

	SN54H76			SN74H76			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V_{IH} High-level input voltage	2			2			V
V_{IL} Low-level input voltage			0.8			0.8	V
I_{OH} High-level output current			-0.5			-0.5	mA
I_{OL} Low-level output current			20			20	mA
t_w Pulse duration	CLK high	12		12			ns
	CLK low	28		28			
	CLR or PRE low	16		16			
t_{su} Setup time before CLK †	data high or low		0	0			ns
t_h Hold time-data after CLK †			0	0			ns
T_A Operating free-air temperature	-55	125		0	70		°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS			SN54H76		SN74H76		UNIT
				MIN	TYP ‡	MAX	MIN	
V_{IK}	$V_{CC} = \text{MIN}, I_I = -8 \text{ mA}$			-1.5		-1.5		V
V_{OH}	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OH} = -0.5 \text{ mA}$			2.4	3.4	2.4	3.4	V
V_{OL}	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OL} = 20 \text{ mA}$			0.2	0.4	0.2	0.4	V
I_I	$V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$			1		1		mA
I_{IH}	J, K, or CLK	$V_{CC} = \text{MAX}, V_I = 2.4 \text{ V}$		50		50		μA
	CLR or PRE			100		100		
I_{IL}	J, K, or CLK	$V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$		-2		-2		mA
	CLR or PRE*			-4		-4		
$I_{OS} \S$	$V_{CC} = \text{MAX}$			-40	-100	-40	-100	mA
I_{CC}	$V_{CC} = \text{MAX}, \text{ See Note 2}$			16	25	16	25	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

* Clear is tested with preset high and preset is tested with clear high.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and \bar{Q} outputs high in turn. At the time of measurement, the clock input is grounded.

switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
f_{max}			$R_L = 280 \Omega,$	$C_L = 25 \text{ pF}$	25	30		MHz
t_{PLH}	$\overline{\text{PRE}}$ or $\overline{\text{CLR}}$	Q or \bar{Q}			6	13		ns
t_{PHL}					12	24		ns
t_{PLH}	CLK	Q or \bar{Q}			14	21		ns
t_{PHL}					22	27		ns

NOTE 3: See General Information Section for load circuits and voltage waveforms.

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TTL DEVICES

TYPES SN54LS76A, SN74LS76A DUAL J-K FLIP-FLOPS WITH PRESET AND CLEAR

recommended operating conditions

		SN54LS76A			SN74LS76A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage	4.5	5	5.5	4.75	5	5.75	V
V _{IH}	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.7			0.8	V
I _{OH}	High-level output current			-0.4			-0.4	mA
I _{OL}	Low-level output current			4			8	mA
f _{clock}	Clock frequency	0	30		0	30		MHz
t _w	Pulse duration	CLK high	20		20			ns
		PRE or CLR low	25		25			
t _{su}	Setup time before CLK↓	data high or low	20		20			ns
		CLR inactive	20		20			
		PRE inactive	25		25			
t _h	Hold time-data after CLK↓	0			0			ns
T _A	Operating free-air temperature	-55	125		0	70		°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	SN54LS76A		SN74LS76A		UNIT
			MIN	TYP‡	MAX	MIN	
V _{IK}		V _{CC} = MIN, I _I = -18 mA	-1.5		-1.5		V
V _{OH}		V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = MAX, I _{OH} = -0.4 mA	2.5	3.4	2.7	3.4	V
V _{OL}		V _{CC} = MIN, V _{IL} = MAX, V _{IH} = 2 V, I _{OL} = 4 mA	0.25	0.4	0.25	0.4	V
		V _{CC} = MIN, V _{IL} = MAX, V _{IH} = 2 V, I _{OL} = 8 mA			0.35	0.5	
I _I	J or K	V _{CC} = MAX, V _I = 7 V	0.1		0.1		mA
	CLR or PRE		0.3		0.3		
	CLK		0.4		0.4		
I _{IH}	J or K	V _{CC} = MAX, V _I = 2.7 V	20		20		μA
	CLR or PRE		60		60		
	CLK		80		80		
I _{IL}	J or K	V _{CC} = MAX, V _I = 0.4 V	-0.4		-0.4		mA
	All other		-0.8		-0.8		
I _{OS} §		V _{CC} = MAX, See Note 4	-20	-100	-20	-100	mA
I _{CC}		V _{CC} = MAX, See Note 2	4	6	4	6	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and \bar{Q} outputs high in turn. At the time of measurement, the clock input is grounded.

NOTE 4: For certain devices where state commutation can be caused by shorting an output to ground, an equivalent test may be performed with V_O = 2.25 V and 2.125 V for the 54 family and the 74 family, respectively, with the minimum and maximum limits reduced to one half of their stated values.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
f _{max}			R _L = 2 kΩ, C _L = 15 pF		30	45		MHz
t _{PLH}	PRE, CLR or CLK	Q or \bar{Q}			15	20		ns
t _{PHL}					15	20		ns

NOTE 3: See General Information Section for load circuits and voltage waveforms.

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TTL DEVICES